

2–16 GHz Low Noise Gallium Arsenide FET

Technical Data

ATF-13336

Features

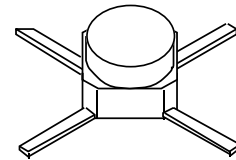
- **Low Noise Figure:**
1.4 dB Typical at 12 GHz
- **High Associated Gain:**
9.0 dB Typical at 12 GHz
- **High Output Power:**
17.5 dBm Typical $P_{1\text{dB}}$ at 12 GHz
- **Cost Effective Ceramic Microstrip Package**
- **Tape-and-Reel Packaging Option Available^[1]**

Description

The ATF-13336 is a high performance gallium arsenide Schottky-barrier-gate field effect transistor housed in a cost effective microstrip package. Its premium noise figure makes this device appropriate for use in low noise amplifiers operating in the 2-16 GHz frequency range.

This GaAs FET device has a nominal 0.3 micron gate length with a total gate periphery of 250 microns. Proven gold based metallization systems and nitride passivation assure a rugged, reliable device.

36 micro-X Package



Electrical Specifications, $T_A = 25^\circ\text{C}$

| Symbol | Parameters and Test Conditions | Units | Min. | Typ. | Max. |
|------------------|--|-----------------------|------|------|------|
| NF _O | Optimum Noise Figure: $V_{DS} = 2.5\text{ V}$, $I_{DS} = 20\text{ mA}$ | $f = 8.0\text{ GHz}$ | | 1.2 | 1.6 |
| | | $f = 12.0\text{ GHz}$ | | 1.4 | |
| | | $f = 14.0\text{ GHz}$ | | 1.6 | |
| G _A | Gain @ NF _O : $V_{DS} = 2.5\text{ V}$, $I_{DS} = 20\text{ mA}$ | $f = 8.0\text{ GHz}$ | | 11.5 | 8.0 |
| | | $f = 12.0\text{ GHz}$ | | 9.0 | |
| | | $f = 14.0\text{ GHz}$ | | 7.5 | |
| P _{1dB} | Power Output @ 1 dB Gain Compression: $V_{DS} = 4\text{ V}$, $I_{DS} = 40\text{ mA}$ | $f = 12.0\text{ GHz}$ | | 17.5 | |
| G _{1dB} | 1 dB Compressed Gain: $V_{DS} = 4\text{ V}$, $I_{DS} = 40\text{ mA}$ | $f = 12.0\text{ GHz}$ | | 8.5 | |
| g _m | Transconductance: $V_{DS} = 2.5\text{ V}$, $V_{GS} = 0\text{ V}$ | mmho | 25 | 55 | |
| I _{DSS} | Saturated Drain Current: $V_{DS} = 2.5\text{ V}$, $V_{GS} = 0\text{ V}$ | mA | 40 | 50 | 90 |
| V _P | Pinch-off Voltage: $V_{DS} = 2.5\text{ V}$, $I_{DS} = 1\text{ mA}$ | V | -4.0 | -1.5 | -0.5 |

Note:

1. Refer to PACKAGING section "Tape-and-Reel Packaging for Surface Mount Semiconductors".

ATF-13336 Absolute Maximum Ratings

| Symbol | Parameter | Units | Absolute Maximum ^[1] |
|------------------|------------------------------------|-------|---------------------------------|
| V _{DS} | Drain-Source Voltage | V | +5 |
| V _{GS} | Gate-Source Voltage | V | -4 |
| V _{GD} | Gate-Drain Voltage | V | -6 |
| I _{DS} | Drain Current | mA | I _{DSS} |
| P _T | Power Dissipation ^[2,3] | mW | 225 |
| T _{CH} | Channel Temperature | °C | 175 |
| T _{STG} | Storage Temperature | °C | -65 to +175 |

Thermal Resistance: $\theta_{jc} = 400^{\circ}\text{C}/\text{W}; T_{CH} = 150^{\circ}\text{C}$
Liquid Crystal Measurement: 1 μm Spot Size^[5]

Notes:

1. Permanent damage may occur if any of these limits are exceeded.
2. T_{CASE TEMPERATURE} = 25°C.
3. Derate at 2.5mW/°C for T_{CASE} > 85°C.
4. Storage above +150°C may tarnish the leads of this package difficult to solder into a circuit. After a device has been soldered into a circuit, it may be safely stored up to 175°C.
4. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section for more information.

Part Number Ordering Information

| Part Number | Devices Per Reel | Reel Size |
|---------------|------------------|-----------|
| ATF-13336-TR1 | 1000 | 7" |
| ATF-13336-STR | 10 | strip |

ATF-13336 Noise Parameters: V_{DS} = 2.5 V, I_{DS} = 20 mA

| Freq. GHz | NF _O dB | Γ_{opt} | | R _N /50 |
|-----------|--------------------|----------------|------|--------------------|
| | | Mag | Ang | |
| 4.0 | 0.8 | .63 | 93 | .27 |
| 6.0 | 1.1 | .47 | 138 | .10 |
| 8.0 | 1.2 | .40 | -153 | .20 |
| 12.0 | 1.4 | .52 | -45 | .88 |
| 14.0 | 1.6 | .57 | -2 | 1.3 |

ATF-13336 Typical Performance, T_A = 25°C

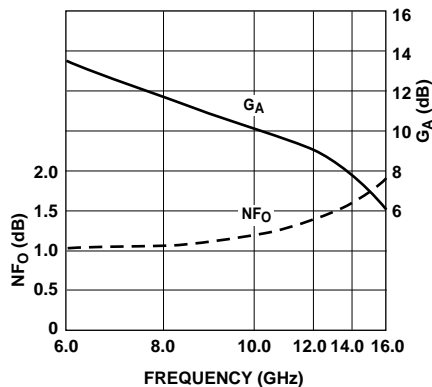


Figure 1. Optimum Noise Figure and Associated Gain vs. Frequency.
V_{DS} = 2.5V, I_{DS} = 20 mA, T_A = 25°C.

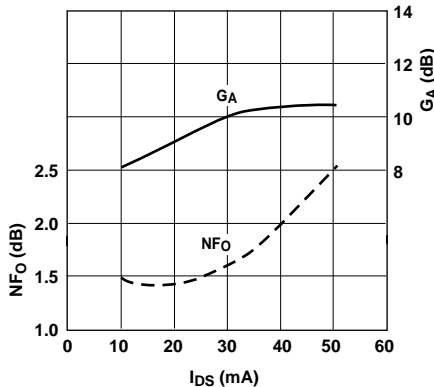


Figure 2. Optimum Noise Figure and Associated Gain vs. I_{DS}.
V_{DS} = 2.5V, f = 12.0 GHz.

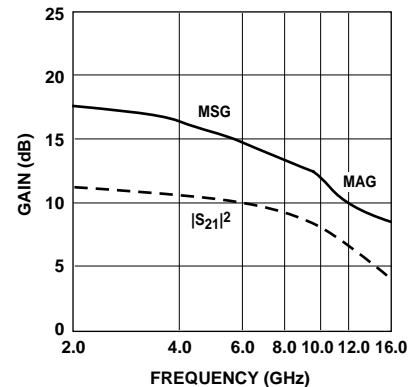


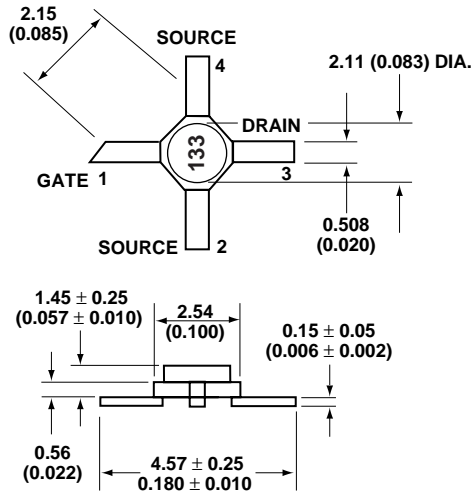
Figure 3. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency.
V_{DS} = 2.5 V, I_{DS} = 20 mA.

Typical Scattering Parameters, Common Emitter, $Z_0 = 50 \Omega$, $T_A = 25^\circ\text{C}$, $V_{DS} = 2.5\text{V}$, $I_{DS} = 20\text{mA}$

| Freq. GHz | S_{11} | | dB | S_{21} | | dB | S_{12} | | S_{22} | |
|--------------|----------|------|------|----------|------|-------|----------|------|----------|------|
| | Mag. | Ang. | | Mag. | Ang. | | Mag. | Ang. | Mag. | Ang. |
| 2.0 | .96 | -51 | 10.6 | 3.39 | 127 | -27.1 | .044 | 57 | .61 | -41 |
| 3.0 | .88 | -75 | 10.3 | 3.28 | 106 | -23.4 | .060 | 33 | .58 | -51 |
| 4.0 | .86 | -96 | 10.1 | 3.19 | 86 | -22.6 | .074 | 25 | .57 | -57 |
| 5.0 | .79 | -117 | 9.9 | 3.13 | 66 | -20.6 | .093 | 12 | .54 | -65 |
| 6.0 | .69 | -142 | 10.2 | 3.22 | 46 | -18.9 | .114 | 1 | .49 | -79 |
| 7.0 | .60 | -178 | 10.1 | 3.21 | 21 | -17.6 | .132 | -18 | .42 | -97 |
| 8.0 | .54 | 141 | 9.8 | 3.10 | -4 | -17.3 | .137 | -33 | .31 | -112 |
| 9.0 | .56 | 103 | 8.9 | 2.80 | -26 | -16.7 | .147 | -48 | .21 | -121 |
| 10.0 | .56 | 74 | 8.3 | 2.60 | -48 | -16.5 | .150 | -63 | .09 | -145 |
| 11.0 | .58 | 44 | 7.6 | 2.39 | -68 | -16.8 | .145 | -78 | .07 | 89 |
| 12.0 | .63 | 20 | 6.7 | 2.17 | -90 | -17.5 | .133 | -95 | .16 | 43 |
| 13.0 | .65 | 3 | 6.0 | 2.00 | -108 | -18.3 | .121 | -107 | .19 | 21 |
| 14.0 | .66 | -7 | 5.5 | 1.89 | -126 | -18.9 | .114 | -121 | .19 | -4 |
| 15.0 | .70 | -19 | 4.9 | 1.76 | -144 | -19.0 | .112 | -129 | .16 | -28 |
| 16.0 | .72 | -34 | 4.4 | 1.66 | -175 | -19.2 | .110 | -142 | .14 | -32 |

A model for this device is available in the DEVICE MODELS section.

36 micro-X Package Dimensions



Notes:

1. Dimensions are in millimeters (inches)
2. Tolerances: in .xxx = ± 0.005
mm .xx = ± 0.13